NCE N-Channel Super Trench Power MOSFET

Description

The NCEP1260F uses **Super Trench** technology that is uniquely optimized to provide the most efficient high frequency switching performance. Both conduction and switching power losses are minimized due to an extremely low combination of $R_{\text{DS(ON)}}$ and Q_g . This device is ideal for high-frequency switching and synchronous rectification.

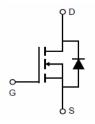
General Features

- V_{DS} =120V, I_D =60A $R_{DS(ON)}$ =10m Ω (typical) @ V_{GS} =10V
- Excellent gate charge x R_{DS(on)} product(FOM)
- Very low on-resistance R_{DS(on)}
- 175 °C operating temperature
- Pb-free lead plating
- 100% UIS tested

Application

- DC/DC Converter
- Ideal for high-frequency switching and synchronous rectification

100% UIS TESTED! 100% ΔVds TESTED!



Schematic diagram



Marking and pin assignment



TO-220F top view

Package Marking and Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
NCEP1260F	NCEP1260F	TO-220F	-	-	-

Absolute Maximum Ratings (T_C=25 ℃unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V _{DS}	120	V
Gate-Source Voltage	V _G S	±20	V
Drain Current-Continuous	I _D	60	А
Drain Current-Continuous(T _C =100℃)	I _D (100℃)	42.4	Α
Pulsed Drain Current	I _{DM}	240	Α
Maximum Power Dissipation	P _D	35	W
Derating factor		0.23	W/°C
Single pulse avalanche energy (Note 5)	E _{AS}	290	mJ
Operating Junction and Storage Temperature Range	T_{J} , T_{STG}	-55 To 175	$^{\circ}$ C

Thermal Characteristic

Thermal Resistance,Junction-to-Case ^(Note 2)	R _{θJC}	4.3	°C/W
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NCEP1260F

Electrical Characteristics (T_C=25 °C unless otherwise noted)

Parameter	Symbol	Condition	Min	Тур	Max	Unit
Off Characteristics						
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V I _D =250μA	120		-	V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =120V,V _{GS} =0V	-	-	1	μA
Gate-Body Leakage Current	I _{GSS}	V _{GS} =±20V,V _{DS} =0V	-	-	±100	nA
On Characteristics (Note 3)						
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}$, $I_{D}=250\mu A$	2	3	4	V
Drain-Source On-State Resistance	R _{DS(ON)}	V _{GS} =10V, I _D =30A	-	10	11	mΩ
Forward Transconductance	g FS	V _{DS} =5V,I _D =30A	-	40	-	S
Dynamic Characteristics (Note4)						
Input Capacitance	C _{lss}	V -00V/V -0V	-	2500	-	PF
Output Capacitance	C _{oss}	V_{DS} =60V, V_{GS} =0V, F=1.0MHz	-	273	-	PF
Reverse Transfer Capacitance	C _{rss}	r-1.0IVIHZ	_	27	-	PF
Switching Characteristics (Note 4)						
Turn-on Delay Time	t _{d(on)}		-	11	-	nS
Turn-on Rise Time	t _r	V_{DD} =50V, I_D =30A	-	7.5	-	nS
Turn-Off Delay Time	t _{d(off)}	V_{GS} =10 V , R_{G} =3 Ω	-	26	-	nS
Turn-Off Fall Time	t _f		-	4	-	nS
Total Gate Charge	Q_g	\/ -60\/ L -20A	-	37		nC
Gate-Source Charge	Q_{gs}	V_{DS} =60V, I_{D} =30A, V_{GS} =10V	_	14		nC
Gate-Drain Charge	Q_{gd}	V _{GS} =10V	-	8		nC
Drain-Source Diode Characteristics			•			
Diode Forward Voltage (Note 3)	V_{SD}	V _{GS} =0V,I _S =60A	-		1.2	V
Diode Forward Current (Note 2)	Is		-	-	60	Α
Reverse Recovery Time	t _{rr}	$T_J = 25^{\circ}C, I_F = I_S$	-	58		nS
Reverse Recovery Charge	Qrr	$di/dt = 100A/\mu s^{(Note3)}$	-	149		nC

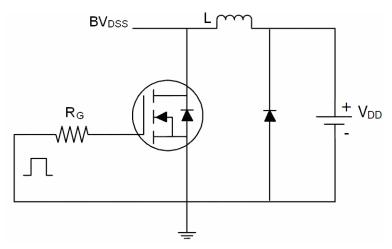
Notes:

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 2. Surface Mounted on FR4 Board, t ≤ 10 sec.
- 3. Pulse Test: Pulse Width ≤ 300µs, Duty Cycle ≤ 2%.
- 4. Guaranteed by design, not subject to production
- 5. EAS condition : Tj=25 $^{\circ}\text{C}$,VDD=50V,VG=10V,L=0.5mH,Rg=25 Ω

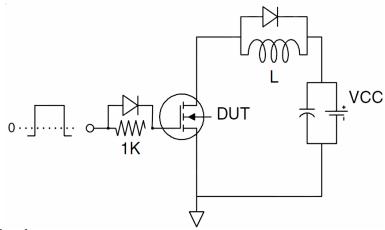


Test Circuit

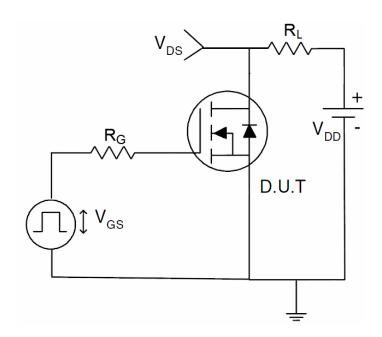
1) E_{AS} test Circuit



2) Gate charge test Circuit



3) Switch Time Test Circuit





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Typical Electrical and Thermal Characteristics

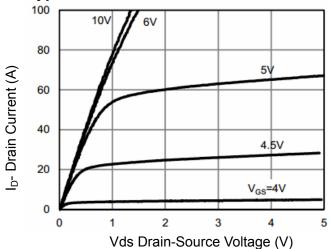


Figure 1 Output Characteristics

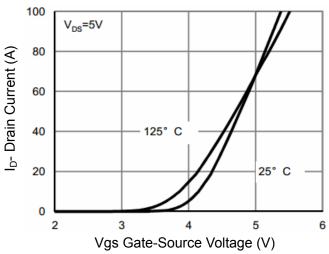


Figure 2 Transfer Characteristics

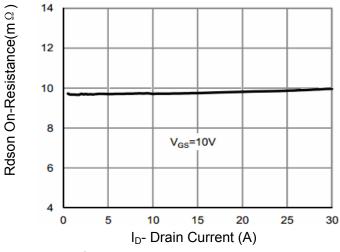


Figure 3 Rdson- Drain Current

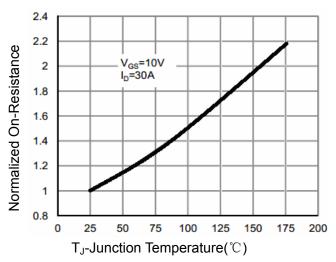


Figure 4 Rdson-JunctionTemperature

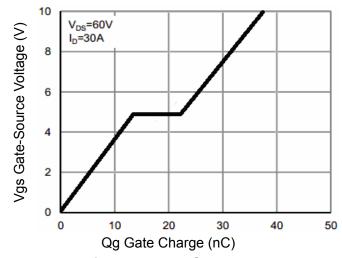


Figure 5 Gate Charge

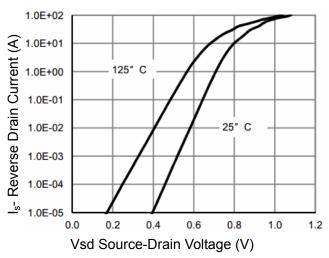
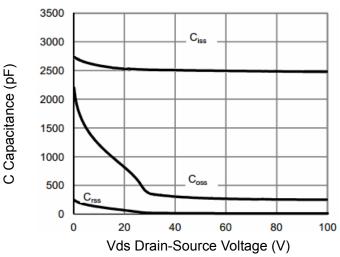


Figure 6 Source- Drain Diode Forward





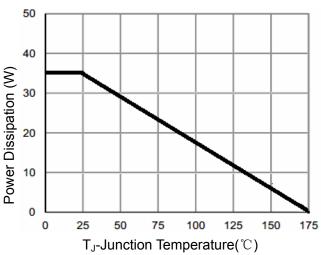
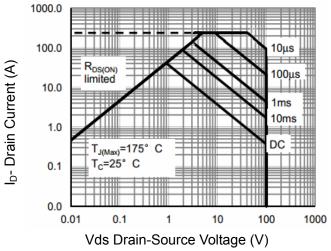


Figure 7 Capacitance vs Vds

Figure 9 Power De-rating



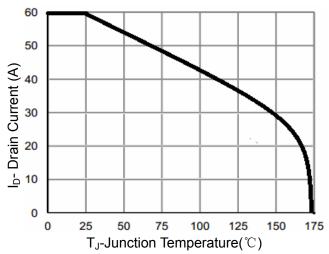


Figure 8 Safe Operation Area

Figure 10 Current De-rating

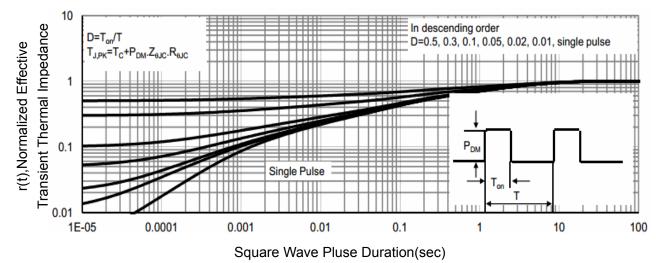
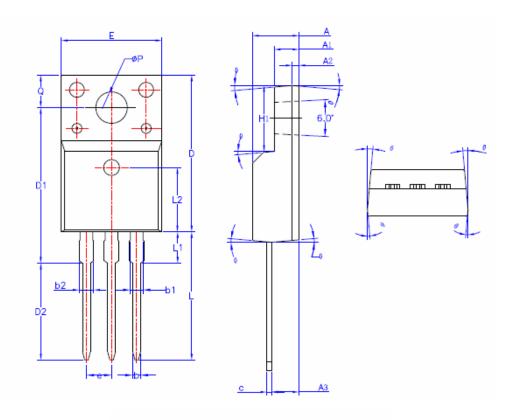


Figure 11 Normalized Maximum Transient Thermal Impedance



TO-220F Package Information



SYMBOL	MIN	NOM	MAX		
Α	4.50	4.70	4.83		
A1	2.34	2.54	2.74		
A2	0.70 REF				
A3	2.56	2.76	2.93		
b	0.70	_	0.90		
b1	1.18	_	1.38		
b2	_	_	1.47		
С	0.45	0.50	0.60		
D	15.67	15.87	16.07		
D1	15.55	15.75	15.95		
D2	9.60	9.80	10.0		
Е	9.96	10.16	10.36		
е	2.54BSC				
H1	6.48	6.68	6.88		
L	12.68	12.98	13.28		
L1	_	_	3.50		
L2	6.50REF				
ØΡ	3.08	3.18	3.28		
Q	3.20	_	3.40		
θ 1	1*	3°	5°		



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NCEP1260F

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